

Abstract Submitted
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Identification of a N-related shallow acceptor and related EPR center in ZnO: N₂ on Zn site¹ WALTER R.L. LAMBRECHT², CWRU, ADISAK BOONCHUN, NIMS, Tsukuba, Japan and Kasetsart Univ., Bangkok — While the deep level of N_O makes it unsuitable for p-type doping of ZnO, a shallow level at about 165±40 meV above the VBM related to N is known to exist in ZnO (Zeuner et al. 2002). Here we show that a N₂ molecule on the Zn site behaves as a shallow acceptor. First-principles calculations show that when N₂ is placed on a Zn site, two electrons are removed from the σ_g^+ HOMO. The molecular levels line up with the ZnO band structure in such a way that the σ_g^+ level forms a resonance near the VBM. In contrast, for N₂ on the O-site, two extra electrons occupy the π_g LUMO of the N₂ molecule and form a donor level. The 0/- transition level of the acceptor is found at ~0.2 eV above the VBM. When singly occupied the defect corresponds to a N₂⁺ radical. We show that the *g*-factor, calculated within a simple tight-binding model, of this radical agrees better with an observed EPR center by Garces et al. (2003) than the N₂⁻ radical. The σ_g nature of the defect wavefunction for N₂ on Zn is consistent with a significant isotropic hyperfine interaction, while the π_g character of N₂ on O is not. The lower value of A_{iso} compared to the isolated molecule is consistent with the shallow nature of the defect.

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